

## **Search Notes**



**Application/Control No.**

10/625,796

**Examiner**

Deborah Yee

**Applicant(s)/Patent under  
Reexamination**

INOUE ET AL.

## Art Unit

1742

SEARCHED

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner